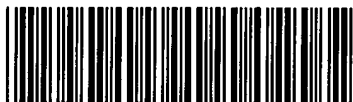


**Search Notes**

Application/Control No.

10/616,525

Examiner

J. Derek Rutten

Applicant(s)/Patent under  
Reexamination

FUNK ET AL.

Art Unit

2192

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS database search  EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	11/21/2006	JDR
Inventor Name search  Rosenberg, "How Debuggers Work"	11/21/2006	JDR
717/129 - text search only See search history printout	11/21/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	11/22/2006	JDR
717/127-130; 714/34,35 Text search only See search history printout	11/22/2006	JDR
Google - www.google.com ACM - www.acm.org See search history printout	11/22/2006	JDR
Tuan Dam (consulted re. 112 1 <sup>st</sup> )	11/28/2006	JDR